

Notice of References Cited	Application/Control No. 10/604,057	Applicant(s)/Patent Under Reexamination SUNAGA ET AL.	
	Examiner Dang T Nguyen	Art Unit 2824	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0142566 A1	07-2003	Sohn et al.	365/201
*	C	US-2003/0210604 A1	11-2003	Jeong et al.	365/233
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NON-PATENT DOCUMENTS

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